MOSFET – Power, Single, P-Channel, UDFN, 2.0x2.0x0.55 mm -20 V, -8.2 A

Features

- UDFN Package with Exposed Drain Pads for Excellent Thermal Conduction
- Low Profile UDFN 2.0x2.0x0.55 mm for Board Space Saving
- Ultra Low R_{DS(on)}
- ESD Diode-Protected Gate
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Optimized for Power Management Applications for Portable Products, such as Cell Phones, Media Tablets, PMP, DSC, GPS, and Others
- Battery Switch
- High Side Load Switch

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

| Parameter | | Symbol | Value | Unit | |
|---|-----------------|--------------------------------------|----------------|-------|---|
| Drain-to-Source Voltage | | V_{DSS} | -20 | V | |
| Gate-to-Source Vol | tage | | V_{GS} | ±8.0 | V |
| Continuous Drain | Steady State | T _A = 25°C | I _D | -8.2 | Α |
| Current (Note 1) Continuous Drain | State | T _A = 85°C | | -5.9 | |
| Current (Note 1) | t ≤ 5 s | T _A = 25°C | | -12.2 | |
| Power Dissipa- tion (Note 1) | Steady State | T _A = 25°C | P _D | 1.7 | W |
| | t ≤ 5 s | T _A = 25°C | | 3.8 | |
| Continuous Drain | Steady | T _A = 25°C | I _D | -5.1 | Α |
| Current (Note 2) | State | T _A = 85°C | | -3.7 | |
| Power Dissipation (Note 2) T _A = 25°C | | P_{D} | 0.7 | W | |
| Pulsed Drain Current tp = 10 μs | | I _{DM} | -25 | Α | |
| Operating Junction and Storage Temperature | | T _J , T _{STG} | -55 to 150 | °C | |
| ESD (HBM, JESD22-A114) | | V _{ESD} | 2000 | V | |
| Source Current (Body Diode) (Note 2) | | Is | -1.7 | Α | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | TL | 260 | °C | |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

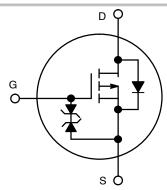
- Surface Mounted on FR4 Board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
- Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.



ON Semiconductor®

www.onsemi.com

| MOSFEI | | | | |
|----------------------|-------------------------|--------------------|--|--|
| V _{(BR)DSS} | R _{DS(on)} MAX | I _D MAX | | |
| | 18 mΩ @ -4.5 V | | | |
| -20 V | 25 mΩ @ -2.5 V | -8.2 A | | |
| 20 1 | 50 mΩ @ –1.8 V | 0.271 | | |
| | 90 mΩ @ -1.5 V | | | |



P-Channel MOSFET

S MARKING DIAGRAM UDFN6 CASE 517BG O AC M -

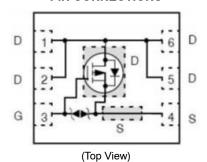
AC = Specific Device Code

M = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PIN CONNECTIONS



ORDERING INFORMATION

See detailed ordering and shipping information on page 5 of this data sheet.

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Max | Unit |
|---|-----------------|-----|------|
| Junction-to-Ambient – Steady State (Note 3) | $R_{\theta JA}$ | 72 | |
| Junction-to-Ambient – t ≤ 5 s (Note 3) | $R_{\theta JA}$ | 33 | °C/W |
| Junction-to-Ambient – Steady State min Pad (Note 4) | $R_{\theta JA}$ | 189 | |

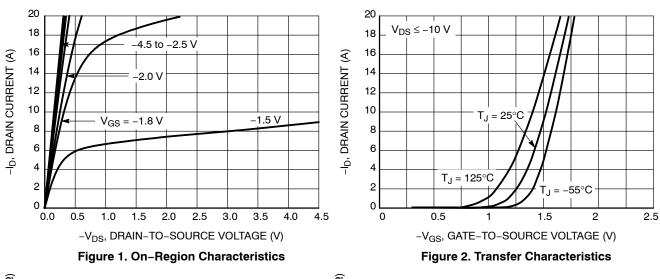
- Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces).
 Surface-mounted on FR4 board using the minimum recommended pad size of 30 mm², 2 oz. Cu.

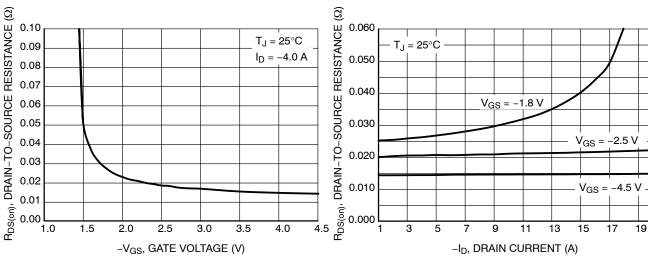
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

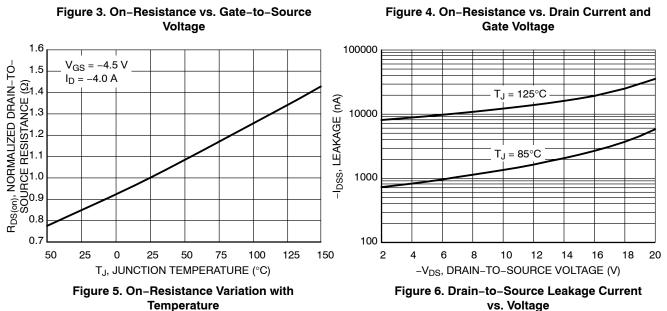
| Parameter | Symbol | Test Condition | | Min | Тур | Max | Units |
|--|--------------------------------------|---|----------------------------|------|------|------|-------|
| OFF CHARACTERISTICS | | | | | | | |
| Drain-to-Source Breakdown Voltage | V _{(BR)DSS} | V _{GS} = 0 V, I | _D = -250 μA | -20 | | | V |
| Drain-to-Source Breakdown Voltage Temperature Coefficient | V _{(BR)DSS} /T _J | $I_D = -250 \mu A$, ref to $25^{\circ}C$ | | | +10 | | mV/°C |
| Zero Gate Voltage Drain Current | I _{DSS} | $V_{GS} = 0 \text{ V},$ $V_{DS} = -20 \text{ V}$ | T _J = 25°C | | | -1.0 | μΑ |
| Gate-to-Source Leakage Current | I _{GSS} | V _{DS} = 0 V, \ | / _{GS} = ±5.0 V | | | ±5 | μΑ |
| ON CHARACTERISTICS (Note 5) | | | | | | | |
| Gate Threshold Voltage | V _{GS(TH)} | $V_{GS} = V_{DS}$, | I _D = -250 μA | -0.4 | | -1.0 | V |
| Negative Threshold Temp. Coefficient | V _{GS(TH)} /T _J | | | | 3.0 | | mV/°C |
| Drain-to-Source On Resistance | R _{DS(on)} | V _{GS} = −4.5 ' | V, I _D = -7.0 A | | 14.6 | 18 | mΩ |
| | | V _{GS} = −2.5 ' | V, I _D = −5.0 A | | 19 | 25 | |
| | | V _{GS} = −1.8 ' | V, I _D = -3.0 A | | 25 | 50 | |
| | | V _{GS} = −1.5 ' | V, I _D = -1.0 A | | 40 | 90 | |
| Forward Transconductance | 9FS | $V_{DS} = -5 \text{ V}, I_D = -3.0 \text{ A}$ | | | 40 | | S |
| CHARGES, CAPACITANCES & GATE | RESISTANCE | | | - | | | |
| Input Capacitance | C _{ISS} | $V_{GS} = 0 \text{ V, f} = 1 \text{ MHz,} $ $V_{DS} = -15 \text{ V}$ | | | 2240 | | pF |
| Output Capacitance | C _{OSS} | | | | 240 | |] |
| Reverse Transfer Capacitance | C _{RSS} | | | | 210 | | |
| Total Gate Charge | Q _{G(TOT)} | $V_{GS} = -4.5 \text{ V}, V_{DS} = -15 \text{ V};$ $I_{D} = -4.0 \text{ A}$ | | | 28 | | nC |
| Threshold Gate Charge | Q _{G(TH)} | | | | 1.0 | | 1 |
| Gate-to-Source Charge | Q_{GS} | | | | 2.9 | | |
| Gate-to-Drain Charge | Q_{GD} | | | | 8.8 | | |
| SWITCHING CHARACTERISTICS, VG | S = 4.5 V (Note 6) | | | | | | |
| Turn-On Delay Time | t _{d(ON)} | | | | 8.6 | | ns |
| Rise Time | t _r | V_{GS} = -4.5 V, V_{DD} = -15 V, I_{D} = -4.0 A, R_{G} = 1 Ω | | | 15 | | |
| Turn-Off Delay Time | t _{d(OFF)} | | | | 150 | | |
| Fall Time | t _f | | | | 88 | | |
| DRAIN-SOURCE DIODE CHARACTER | RISTICS | • | | • | | | |
| Forward Diode Voltage | V_{SD} | $V_{GS} = 0 \text{ V}, \qquad T_{J} = 25^{\circ}\text{C}$ | | | 0.63 | 1.0 | V |
| | | $I_{S} = -1.0 \text{ A}$ | T _J = 125°C | | 0.50 | | |
| Reverse Recovery Time | t _{RR} | V _{GS} = 0 V, dls/dt = 100 A/μs, I _S = -1.0 A | | | 26.1 | | ns |
| Charge Time | t _a | | | | 10.2 | | |
| Discharge Time | t _b | | | | 15.9 | | |
| Reverse Recovery Charge | Q _{RR} | | | | 12 | | nC |

- 5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.
 6. Switching characteristics are independent of operating junction temperatures.

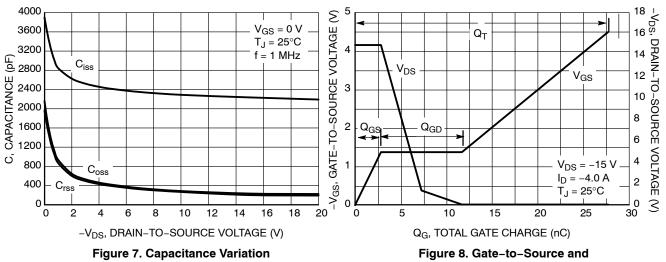
TYPICAL CHARACTERISTICS







TYPICAL CHARACTERISTICS



Drain-to-Source Voltage vs. Total Charge

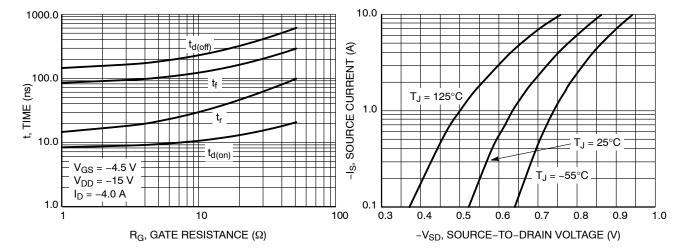


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

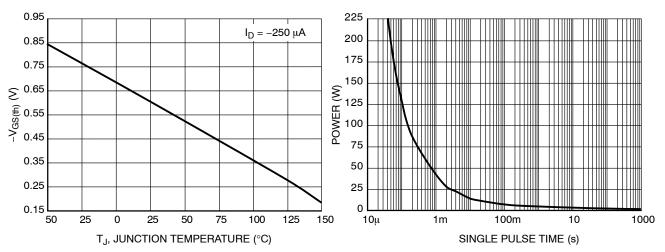


Figure 11. Threshold Voltage

Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

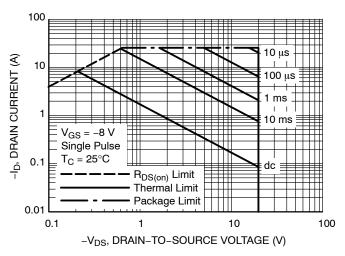


Figure 13. Maximum Rated Forward Biased Safe Operating Area

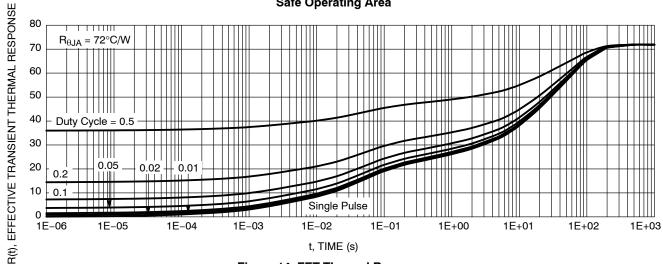


Figure 14. FET Thermal Response

DEVICE ORDERING INFORMATION

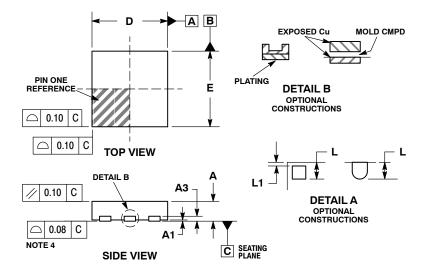
| Device | Package | Shipping [†] |
|----------------|--------------------|-----------------------|
| NTLUS3A18PZTAG | UDFN6 (Pb-Free) | 3000 / Tape & Reel |
| NTLUS3A18PZTBG | UDFN6 (Pb-Free) | 3000 / Tape & Reel |
| NTLUS3A18PZTCG | UDFN6 (Pb-Free) | 3000 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

UDFN6 2x2, 0.65P

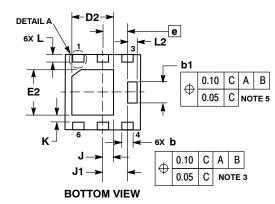
CASE 517BG **ISSUE A**



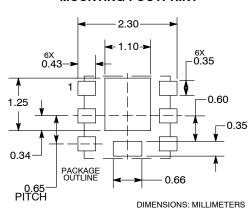
NOTES

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM TERMINAL
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.
- CENTER TERMINAL LEAD IS OPTIONAL. CENTER TERMINAL
- IS CONNECTED TO TERMINAL LEAD # 4.
 6. LEADS 1, 2, 5 AND 6 ARE TIED TO THE FLAG

| | MILLIMETERS | | |
|-----|-------------|------|--|
| DIM | MIN | MAX | |
| Α | 0.45 | 0.55 | |
| A1 | 0.00 | 0.05 | |
| A3 | 0.13 REF | | |
| b | 0.25 | 0.35 | |
| b1 | 0.51 | 0.61 | |
| D | 2.00 BSC | | |
| D2 | 1.00 | 1.20 | |
| E | 2.00 BSC | | |
| E2 | 1.10 | 1.30 | |
| е | 0.65 BSC | | |
| K | 0.15 REF | | |
| 7 | 0.27 BSC | | |
| J1 | 0.65 BSC | | |
| L | 0.20 | 0.30 | |
| L1 | | 0.10 | |
| L2 | 0.20 | 0.30 | |



RECOMMENDED MOUNTING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and the (III) are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

Europe, Middle East and Africa Technical Support: Phone: 421 33 790 2910 Japan Customer Focus Center

Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative